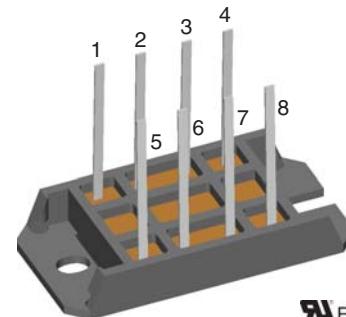
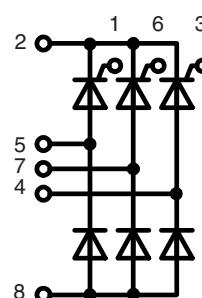


Three Phase Half Controlled Rectifier Bridge

I_{dAVM} = 27 A
V_{RRM} = 1200/1600 V

| V _{RSM} | V _{RRM} | Type |
|------------------|------------------|--------------|
| V _{DSM} | V _{DRM} | |
| V | V | |
| 1300 | 1200 | VVZ 24-12io1 |
| 1700 | 1600 | VVZ 24-16io1 |



E72873

| Symbol | Conditions | Maximum Ratings | | |
|---------------------------------------|---|--|---------------------------|--------------------------------------|
| I _{dAV} | T _K = 100°C; module | 21 | A | |
| I _{dAVM} | module | 27 | A | |
| I _{FRMS} , I _{TRMS} | per leg | 16 | A | |
| I _{FSM} , I _{TSM} | T _{VJ} = 45°C; V _R = 0 | t = 10 ms (50 Hz), sine t = 8.3 ms (60 Hz), sine | 300 320 | A A |
| | T _{VJ} = T _{VJM} V _R = 0 | t = 10 ms (50 Hz), sine t = 8.3 ms (60 Hz), sine | 270 290 | A A |
| I ² t | T _{VJ} = 45°C V _R = 0 | t = 10 ms (50 Hz), sine t = 8.3 ms (60 Hz), sine | 450 430 | A ² s A ² s |
| | T _{VJ} = T _{VJM} V _R = 0 | t = 10 ms (50 Hz), sine t = 8.3 ms (60 Hz), sine | 365 350 | A ² s A ² s |
| (di/dt) _{cr} | T _{VJ} = T _{VJM} f = 400 Hz, t _p = 200 μs V _D = 2/3 V _{DRM} I _G = 0.3 A, di _G /dt = 0.3 A/μs | repetitive, I _T = 50 A non repetitive, I _T = 1/3 • I _{dAV} | 150 500 | A/μs A/μs |
| (dv/dt) _{cr} | T _{VJ} = T _{VJM} ; V _{DR} = 2/3 V _{DRM} R _{gk} = ∞; method 1 (linear voltage rise) | | 1000 | V/μs |
| V _{RGM} | | 10 | | V |
| P _{GM} | T _{VJ} = T _{VJM} I _T = I _{TAVM} | t _p = 30 μs t _p = 500 μs t _p = 10 ms | ≤ 10 ≤ 5 ≤ 1 0.5 | W W W W |
| P _{GAVM} | | | | |
| T _{VJ} | | | -40...+125 | °C |
| T _{VJM} | | | 125 | °C |
| T _{stg} | | | -40...+125 | °C |
| V _{ISOL} | 50/60 Hz, RMS I _{ISOL} ≤ 1 mA | t = 1 min t = 1 s | 3000 3600 | V~ V~ |
| M _d | Mounting torque | (M5) (10-32 UNF) | 2-2.5 18-22 | Nm lb.in. |
| Weight | typ. | | 28 | g |

Data according to IEC 60747 and refer to a single thyristor/diode unless otherwise stated.

IXYS reserves the right to change limits, test conditions and dimensions.

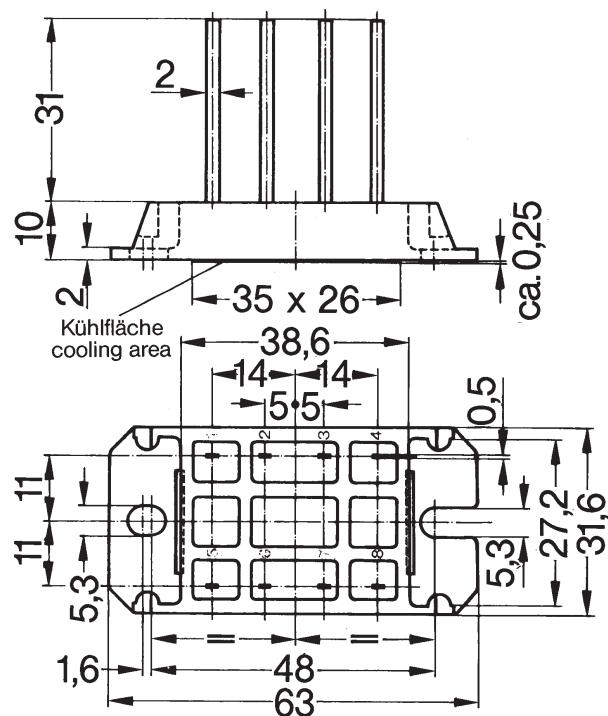
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1 - 3

| Symbol | Conditions | Characteristic Values | | |
|------------|---|-----------------------|------|---------|
| I_R, I_D | $V_R = V_{RRM}; V_D = V_{DRM}$ $T_{VJ} = T_{VJM}$ $T_{VJ} = 25^\circ C$ | \leq | 5 | mA |
| | | \leq | 0.3 | mA |
| V_F, V_T | $I_F, I_T = 30 A, T_{VJ} = 25^\circ C$ | \leq | 1.45 | V |
| V_{TO} | For power-loss calculations only | | 1 | V |
| r_T | $(T_{VJ} = 125^\circ C)$ | | 16 | mΩ |
| V_{GT} | $V_D = 6 V;$ $T_{VJ} = 25^\circ C$ $T_{VJ} = -40^\circ C$ | \leq | 1.0 | V |
| | | \leq | 1.2 | V |
| I_{GT} | $V_D = 6 V;$ $T_{VJ} = 25^\circ C$ $T_{VJ} = -40^\circ C$ $T_{VJ} = 125^\circ C$ | \leq | 65 | mA |
| | | \leq | 80 | mA |
| | | \leq | 50 | mA |
| V_{GD} | $T_{VJ} = T_{VJM};$ | \leq | 0.2 | V |
| I_{GD} | $T_{VJ} = T_{VJM};$ | \leq | 5 | mA |
| I_L | $I_G = 0.3 A; t_G = 30 \mu s$ $di_G/dt = 0.3 A/\mu s$ | \leq | 150 | mA |
| | | \leq | 200 | mA |
| | | \leq | 100 | mA |
| I_H | $T_{VJ} = 25^\circ C; V_D = 6 V; R_{GK} = \infty$ | \leq | 100 | mA |
| t_{gd} | $T_{VJ} = 25^\circ C; V_D = 1/2 V_{DRM}$ $I_G = 0.3 A; di_G/dt = 0.3 A/\mu s$ | \leq | 2 | μs |
| t_q | $T_{VJ} = 125^\circ C; I_T = 15 A, t_p = 300 \mu s, -di/dt = 10 A/\mu s$ | typ. | 150 | μs |
| Q_r | $V_R = 100 V, dv/dt = 20 V/\mu s, V_D = 2/3 V_{DRM}$ | | 75 | μC |
| R_{thJC} | per thyristor (diode); DC current | | 2.1 | K/W |
| | per module | | 0.35 | K/W |
| R_{thJH} | per thyristor (diode); DC current | | 2.7 | K/W |
| | per module | | 0.45 | K/W |
| d_s | Creeping distance on surface | | 7 | mm |
| d_A | Creepage distance in air | | 7 | mm |
| a | Max. allowable acceleration | | 50 | m/s^2 |

Dimensions in mm (1 mm = 0.0394")



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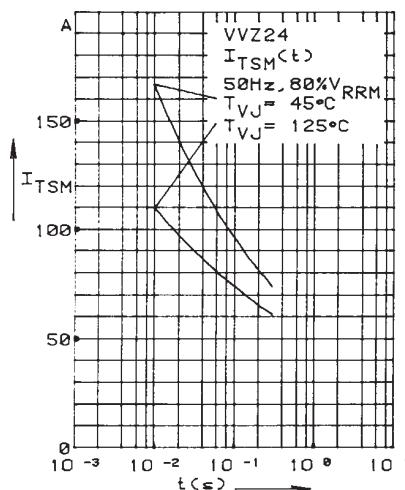


Fig. 1 Surge overload current per chip
 I_{TSM} : Crest value, t : duration

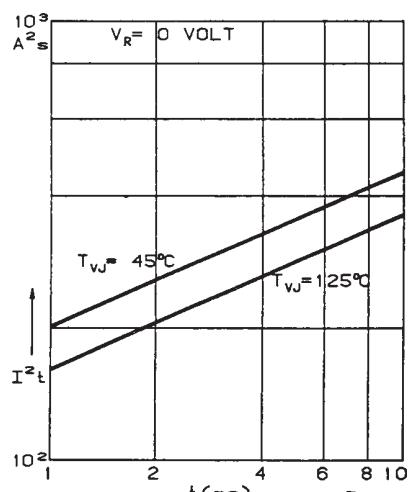


Fig. 2 I^2t versus time (1-10 ms)
per chip

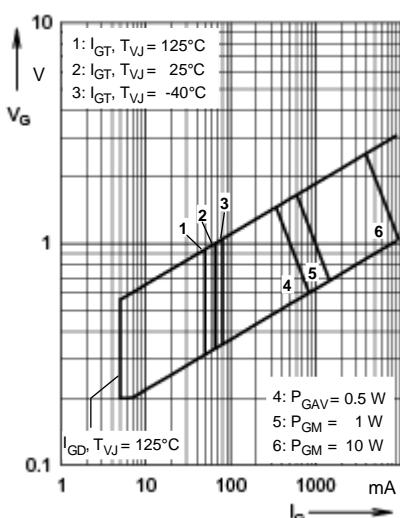


Fig. 3 Gate trigger characteristics
Triggering

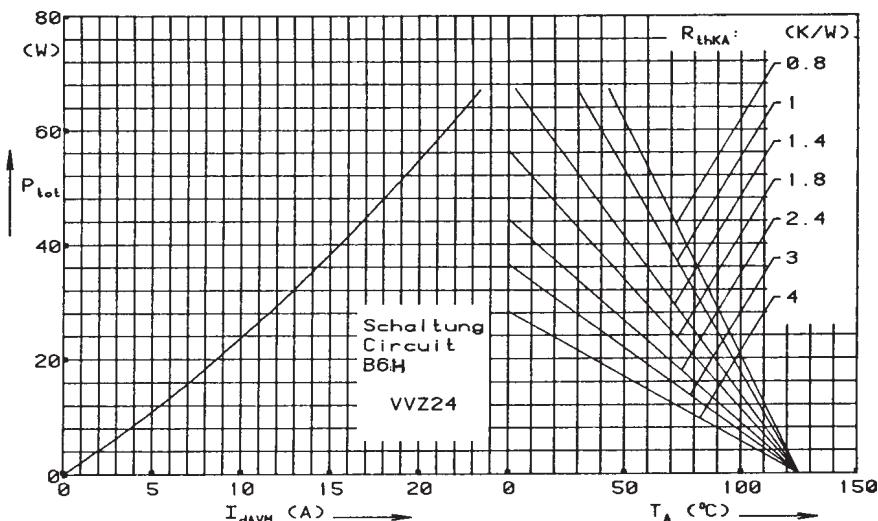


Fig. 4 Power dissipation versus direct output current and ambient temperature

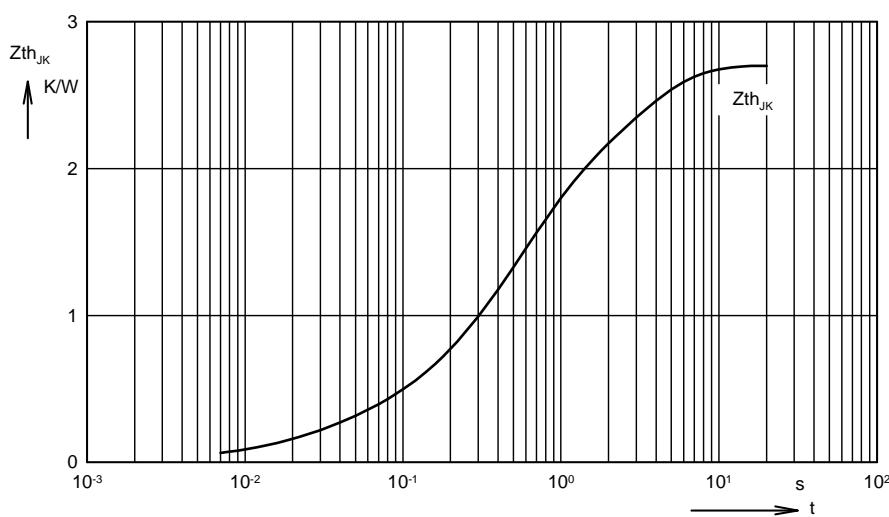


Fig. 5 Transient thermal impedance junction to heatsink

Constants for Z_{thJK} calculation

| i | R_{thi} (K/W) | t_i (s) |
|---|-----------------|-----------|
| 1 | 0.17 | 0.028 |
| 2 | 1.4 | 0.44 |
| 3 | 1.1 | 2.6 |